

N-Channel Power MOSFET

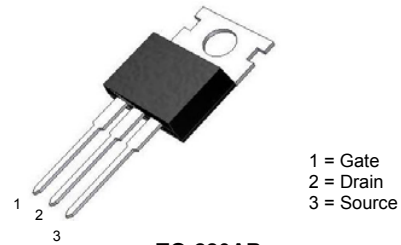
50A, 60V, 0.023Ω

GENERAL DESCRIPTION

This N-Channel MOSFET is used an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance. This device is well suited for high efficiency switched mode power suppliers, active power factor correction, electronic lamp ballasts based half bridge topology.

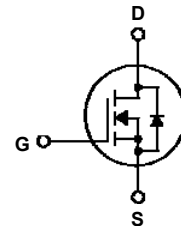
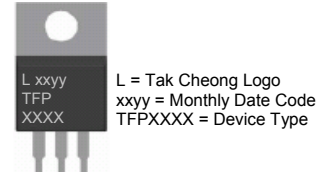
FEATURES

- Avalanche energy specified
- Gate Charge (Typical 36nC)
- High Ruggedness



TO-220AB

DEVICE MARKING DIAGRAM



ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise noted)

Symbol	Parameter	Value	Units
V _{DSS}	Drain- Source Voltage	60	V
V _{GSS}	Gate-Source Voltage	± 25	V
I _D	Drain Current	50	A
I _{DM}	Drain Current Pulsed	200	A
P _D	Power Dissipation (Note 2)	120	W
	Derating Factor above 25°C	0.8	W/°C
E _{AS}	Single Pulsed Avalanche Energy (Note 1)	642	mJ
E _{AR}	Repetitive Avalanche Energy (Note 2)	12	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	7.0	V/ns
T _J	Operating Junction Temperature	150	°C
T _{stg}	Storage Temperature Range	- 55 to +150	°C

Notes:

1. L=300uH, I_{AS}=50A, V_{DD}=25V, R_G=50 Ω, Starting T_J=25°C.
2. Repetitive Rating: Pulse width limited by maximum junction temperature.
3. I_{SD} ≤ 50A, di/dt ≤ 300A/us, V_{DD} ≤ BV_{DSS}, Starting T_J=25°C.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	1.25	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

Number: DB-228
August 2011, Revision A

ELECTRICAL CHARACTERISTICS
Off Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	60	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 60V, V_{GS} = 0V$	--	--	1	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 25V, V_{DS} = 0V$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -25V, V_{DS} = 0V$	--	--	-100	nA

On Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.0	--	4.0	V
$R_{DS(ON)}$	On-Resistance	$V_{GS} = 10V, I_D = 25A$	--	0.017	0.023	Ω

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$ $f = 1.0\text{MHz}$	--	---	1460	pF
C_{oss}	Output Capacitance		--	---	580	pF
C_{rss}	Reverse Transfer Capacitance		--	---	90	pF

Switching Characteristics

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 30V, I_D = 25A,$ $R_G = 25\Omega$ (Note 4 & 5)	--	50	--	nS
t_r	Turn-On Rise Time		--	165	--	nS
$t_{d(off)}$	Turn-Off Delay Time		--	78	--	nS
t_f	Turn-Off Fall Time		--	60	--	nS
Q_g	Total Gate Charge	$V_{DS} = 160V, I_D = 8.0A,$	--	36	45	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 10V$	--	8.5	--	nC
Q_{gd}	Gate-Drain Charge	(Note 4 & 5)	--	12	--	nC

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_S	Continuous Drain-Source Current	Integral Reverse p-n Junction Diode in the MOSFET	--	--	50	A
I_{SM}	Pulsed Drain-Source Current		--	--	200	A
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0V, I_S = 50A$	--	--	1.5	V
T_{rr}	Reverse Recovery Time	$V_{GS} = 0V, I_S = 50A,$ $di_F / dt = 100A/\mu S$	--	95	--	nS
Q_{rr}	Reverse Recovery Charge	(Note 4)	--	250	--	μC

Notes:

4. Pulse Test: Pulse width < 300 μs , Duty cycle $\leq 2\%$.
5. Basically not affected by working temperature.

TYPICAL CHARACTERISTICS

Fig 1. On-State Characteristics

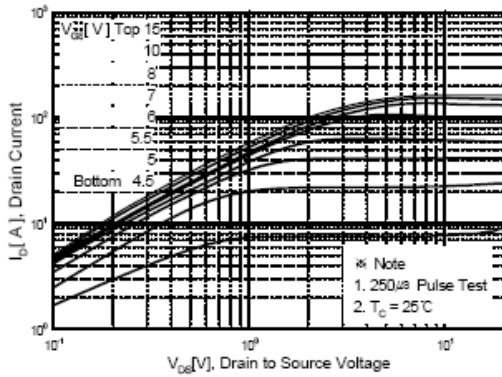


Fig 2. Transfer Characteristics

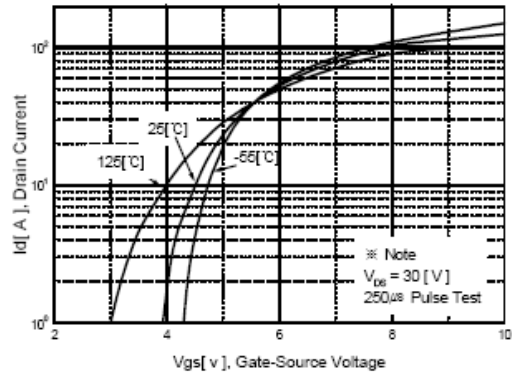


Fig 3. On Resistance Variation vs. Drain Current and Gate Voltage

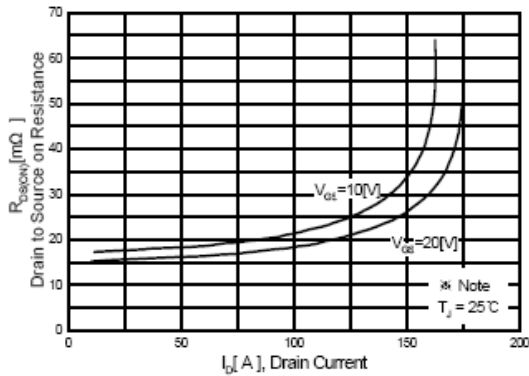


Fig 4. On State Current vs. Allowable Case Temperature

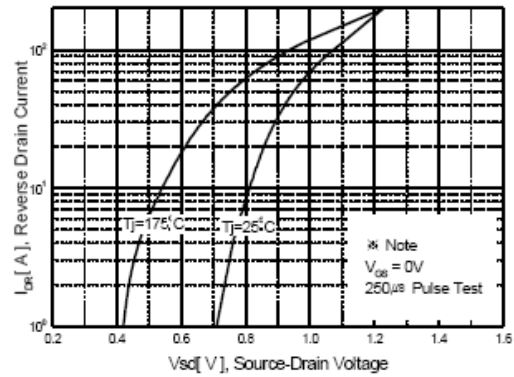


Fig 5. Capacitance Characteristics

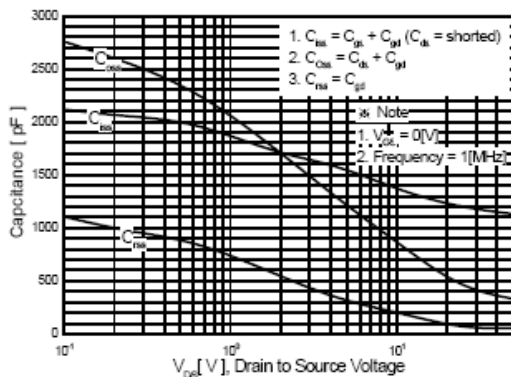


Fig 6. Gate Charge Characteristics

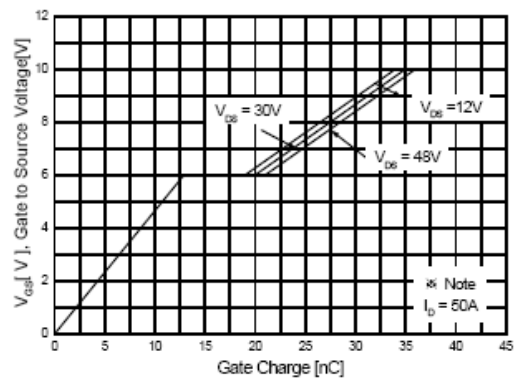


Fig 7. Breakdown Voltage variation vs. Temperature

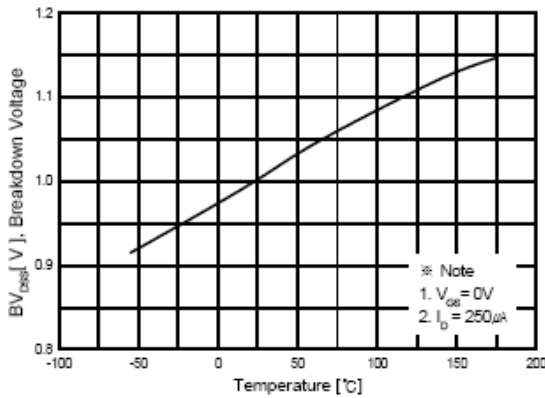


Fig 8. On Resistance variation vs. Temperature

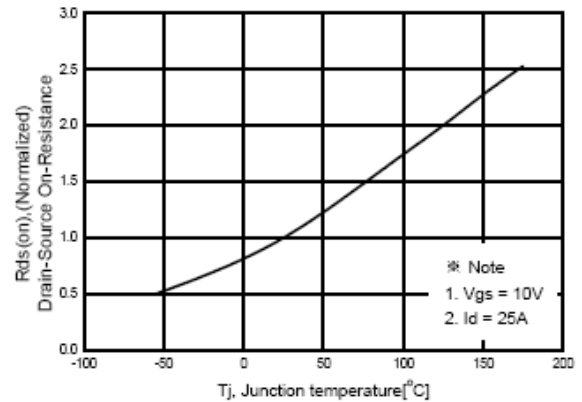


Fig 9. Maximum Safe Operating Area

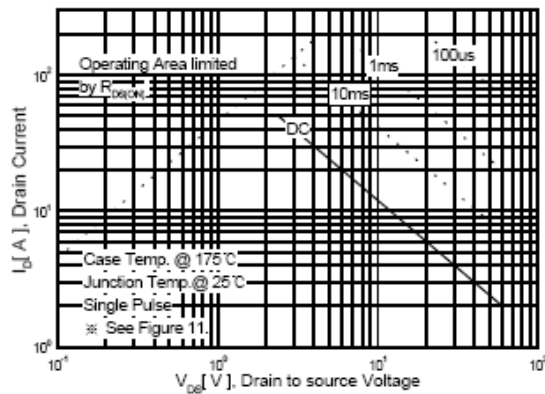


Fig 10. Maximum Drain Current vs. Case Temperature

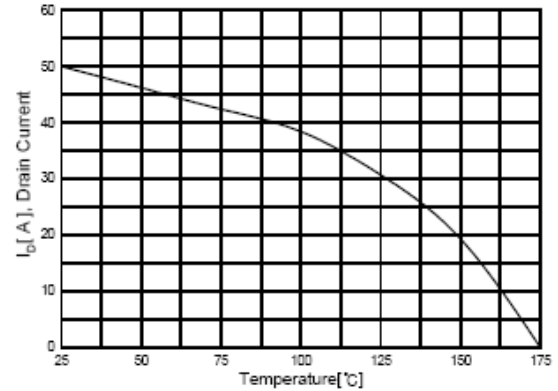


Fig 11. Transient Thermal Response Curve

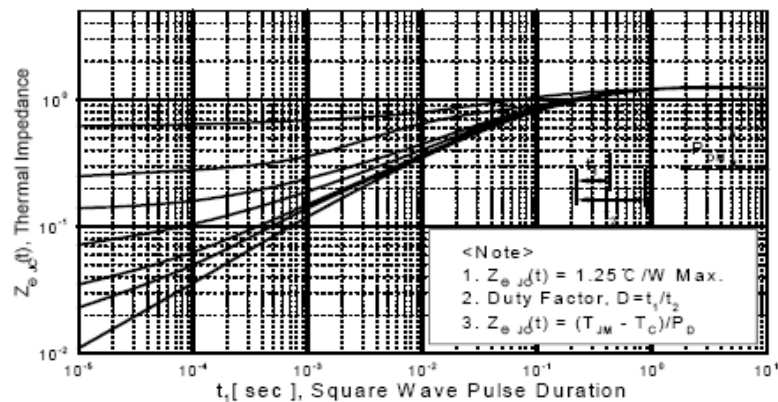


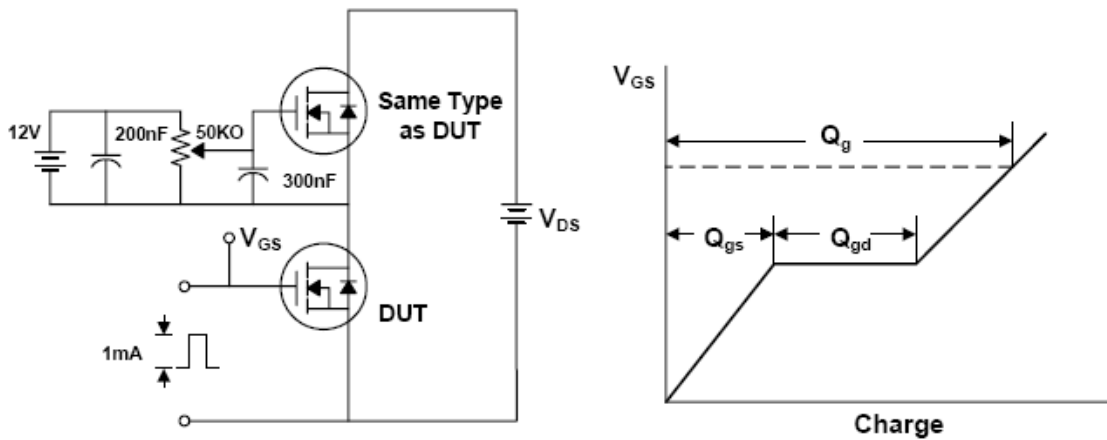
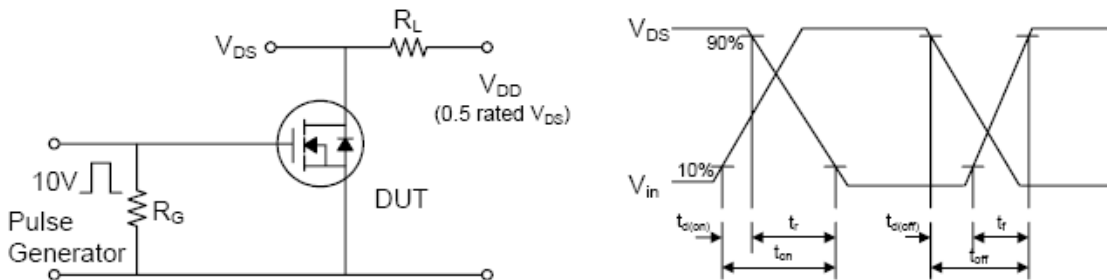
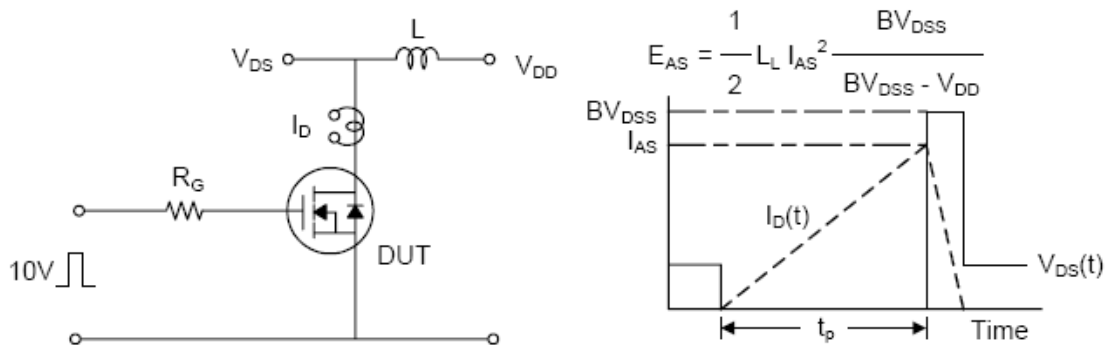
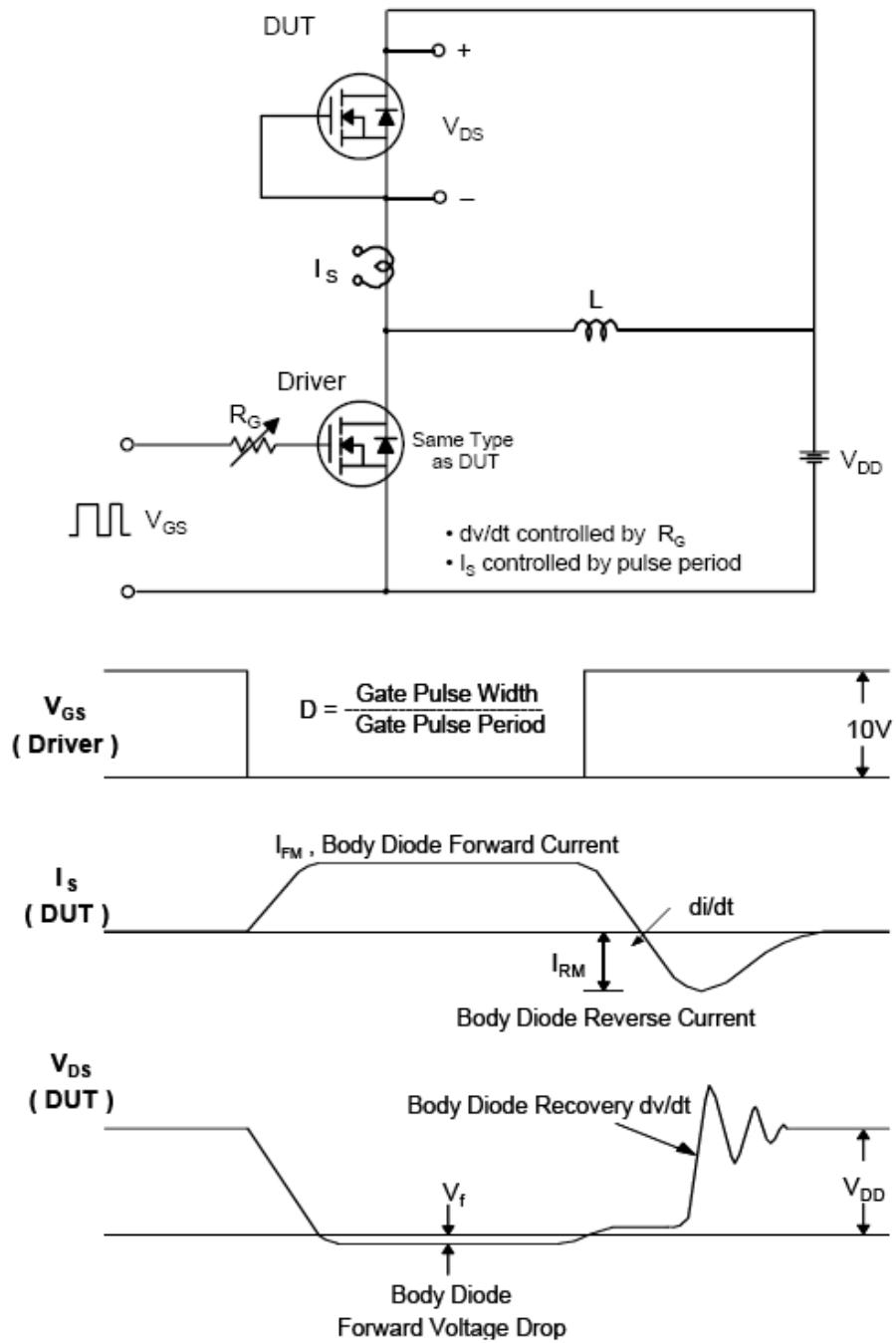
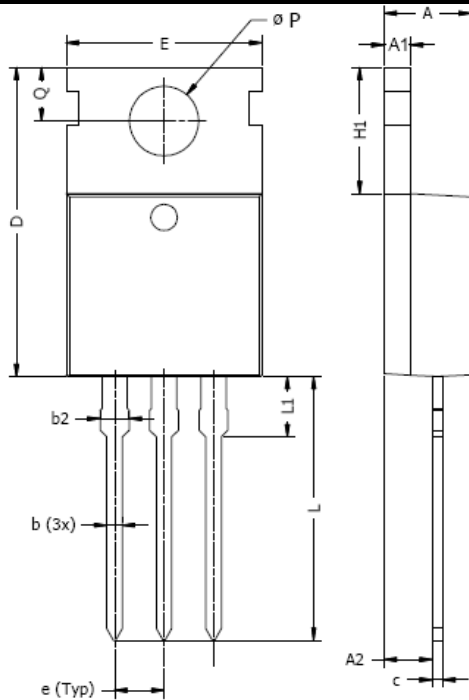
Fig. 12. Gate Charge Test Circuit & Waveforms

Fig 13. Switching Time Test Circuit & Waveforms

Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms


Fig. 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



TO220AB PACKAGE OUTLINE



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	3.60	4.80	0.142	0.189
A1	1.20	1.40	0.047	0.055
A2	2.03	2.90	0.080	0.114
b	0.40	1.00	0.016	0.039
b2	1.20	1.78	0.047	0.070
c	0.36	0.60	0.014	0.024
D	14.22	16.50	0.560	0.650
e	2.34	2.74	0.092	0.108
E	9.70	10.60	0.382	0.417
H1	5.84	6.85	0.230	0.270
L	12.70	14.70	0.500	0.579
L1	2.70	3.30	0.106	0.130
$\varnothing P$	3.50	4.00	0.138	0.157
Q	2.54	3.40	0.100	0.134

NOTE: Above package outline conforms to JEDEC TO-220AB

NOTICE

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